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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT PTO FORM 1449</b>	Atty. Docket No. 10537/105	Serial No. To be assigned
	Applicant(s) SAGEL et al.	
	Filing Date Herewith	Group Art Unit <del>To be assigned</del> 1775

## U. S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE
<i>Shu</i>	5,389,226	February 14, 1995	Scruggs et al.	—	—	

## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
						YES	NO
<i>Shu</i>	10-096077	April 14, 1998	JP	—	—	X*	
<i>Shu</i>	92/13111	August 6, 1992	WO	—	—	X*	
<i>Shu</i>	0 354 391	February 14, 1990	EP	—	—	X*	
<i>Shu</i>	42 16 150	November 19, 1992	DE	—	—	X*	
<i>Shu</i>	0 576 366	December 29, 1993	EP	—	—	X*	
<i>Shu</i>	38 00 454	July 20, 1989	DE	—	—	X+	
<i>Shu</i>	38 14 444	November 17, 1988	DE	—	—	X+	

\* - English translation of the International Search Report provided.

+ - Described in specification.

## OTHER DOCUMENTS

EXAMINER'S INITIALS	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
<i>Shu</i>	Chemical Abstracts, vol. 123, no. 6, Abstract no. 62895, XP-002136889, August 7, 1995.*
<i>Shu</i>	Chemical Abstracts, vol. 113, no. 6, Abstract no. 50666, XP-002136890, August 6, 1990.*
<i>Shu</i>	Database WPI, Section Ch, Week 198941, Derwent Publications Ltd., London, GB, Class M13, AN 1989-293337, XP-002136891.*
<i>Shu</i>	Metall, Volume 36, August 1982, pp. 841-853. +

\* - English translation of the International Search Report provided.

+ - Described in specification.

EXAMINER <i>Shu</i>	DATE CONSIDERED 4/16/03
EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	



<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT PTO FORM 1449</b>	Atty. Docket No. 10537/105	Serial No. 09/868,597
	Applicant(s) SAGEL et al.	
	Filing Date June 19, 2001	Group Art Unit To be assigned 1775

U. S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
						YES	NO
<i>SM</i>	689 03 073	July 5, 1990	DE	—	—	X**	

\* - Described in specification.

+ - English abstract provided.

OTHER DOCUMENTS

EXAMINER'S INITIALS		AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.
<i>SM</i>		U. Gonser, et al., "Metallwissenschaft und Technik", Metall, Volume 36, August 1982, pp. 841-853. *

\* - Described in specification.

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